

Designing Semiconductors from the Assembly of Close-Packed Slabs

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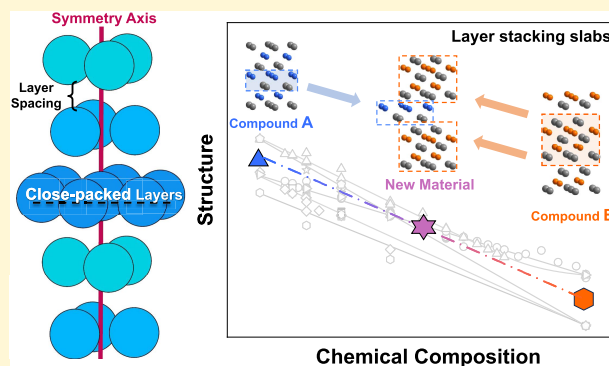
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ABSTRACT: The crystal structures significantly affect the electrical, optical, and mechanical properties of materials, leading to exotic physical phenomena in advanced functional materials. Solid solutions are often employed for crystal manipulation with the goal of discovering new atomic structures possessing novel properties. A practical guideline for adjusting the atomic structure symmetry of different materials is highly expected for the design of functional materials. By examining the similarity of close-packed layers in inorganic materials with different functionalities, a linear dependency between structural symmetry and composition is revealed. “Layer stacking slabs” can serve as a concise and practical pathway for structural manipulation by layer-stacking-unit rearrangement, which is promising for designing materials with various crystal symmetries and characteristics. This layer-stacking-oriented structure manipulation is further confirmed by X-ray diffraction, transmission electron microscopy imaging, and synchrotron X-ray pair distribution function analysis. Following the close-packed layer spacing guidance, a new possible thermoelectric material system of $(I-V-VI_2)-(V_2-VI_3)$ has been experimentally synthesized in this work, thereby expanding the range of thermoelectric candidates. The layer-spacing-based structural indicator exhibits the potential for accelerating the exploration of new functional materials across different application fields.



1. INTRODUCTION

Materials with novel structures, such as honeycomb lattices, perovskites, and metal–organic frameworks (MOFs), often boost advancements in various application fields, yielding exceptional properties derived from their unique atomic arrangements.^{1–3} The physical properties of materials are deeply affected by their crystal structures.^{4–10} The geometric arrangement of atoms plays an important role in determining electronic structures, atomic interactions, and molecular functions, thereby influencing advanced material functionalities, such as electrical, optical, and mechanical properties.

For layered structure materials, the inherent van der Waals layers result in remarkably different properties in the intra- and interlayer directions. For example, layered semiconductors like Bi_2Te_3 and InSe exhibit higher electrical and thermal conductivity along the intralayer direction compared to the interlayer direction.^{11–14} Thus, an insight into the relationship between intra- and interlayer information will provide an opportunity to manipulate functionalities.

In our previous work, the close-packed layer spacing was suggested as a practical guideline for monitoring the crystal symmetry evolution in solid solutions.¹⁵ The layer spacing indicator, based on both interlayer (layer spacing between different planes along the symmetry axis in Figure 1A) and

intralayer (nearby atoms' distance on the same plane normal to the symmetry axis in Figure 1A) structural information, as schemed in Figure 1A, can effectively describe the structure symmetry across crystal systems and manipulate the crystal structure through solid solutions.

To fine-tune the crystal structure of materials, alloying within the same space group or element group is usually implemented to obtain stable solid solutions. On the other hand, the solid solution of different material groups could potentially lead to the discovery of novel functional materials. The layer spacing indicator is capable of exploring new solid solution systems and further extending the range of functional material candidates.

In this study, a comprehensive literature review of crystallographic data from a wide range of publications spanning several crystal systems and functionalities has been conducted.^{16–105} The intrinsic close-packed atomic layers (or

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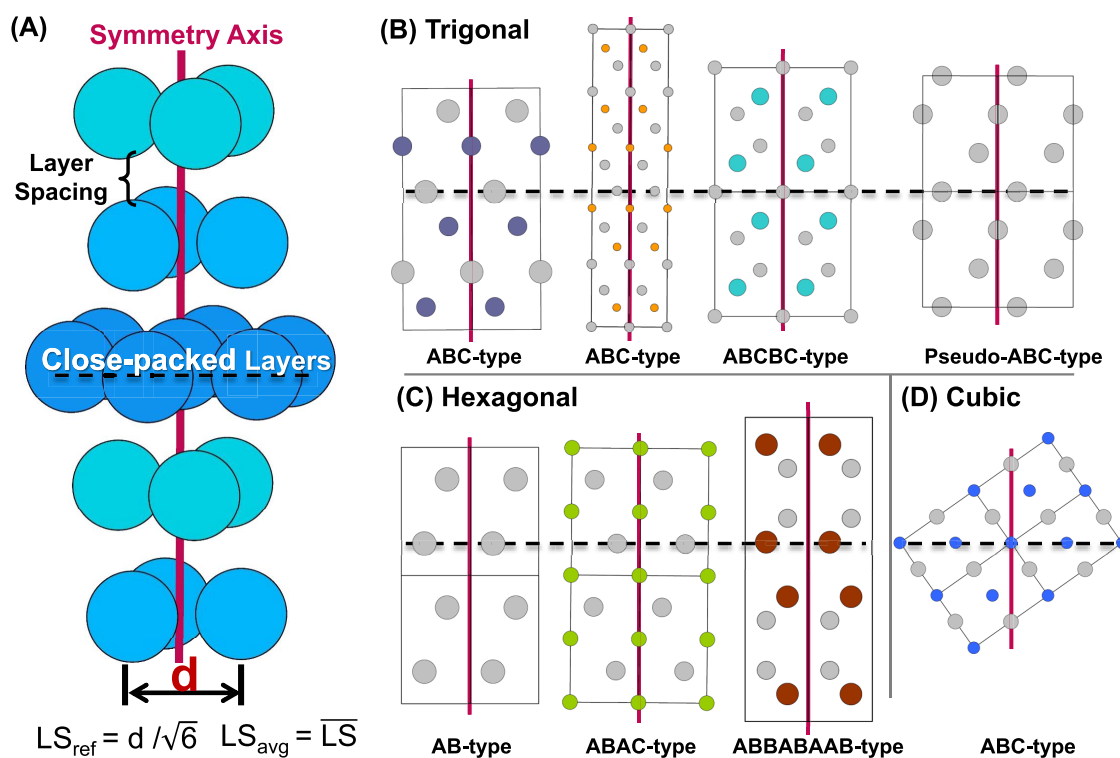


Figure 1. (A) Schematics of close-packed stacking and structures with close-packed layers. Some representative structures of (B) trigonal crystal structures (GeTe, $R3m$; Bi_2Te_3 , $R3m$; Mg_3Sb_2 , $P3m1$, Se, $P3_121$), (C) hexagonal crystal structures (Cd, $P6_3/mmc$, MnTe, $P6_3/mmc$, InSe, $P6_3/mmc$), and (D) cubic crystal structures (FeSe, $Fm3m$).

approximations) lead to the manipulation of structural units through “layer stacking slabs”, which can describe the process of structure formation across different structure types of compounds. Remarkably, a linear relationship between the structure and composition has been revealed across various functional material systems. High-angle annular dark-field scanning transmission electron microscopy (HAADF-STEM) was used to directly observe structural units in classic thermoelectric materials at the atomic scale. The synchrotron X-ray pair distribution function (PDF) local structure analysis was applied to quantitatively measure the evolution of atomic bond lengths. Guided by the close-packed layer spacing indicator, a new thermoelectric material system of $(I-V-VI_2)-(V_2-VI_3)$ has been successfully synthesized. The comprehensive literature review and experimental work across different fields of functional materials suggest that layer stacking can serve as a promising pathway for exploring advanced materials.

2. STRUCTURAL SIMILARITY IN FUNCTIONAL MATERIALS

The functionalities of materials are intrinsically linked to their crystal structures; therefore, manipulation of atomic arrangements has always been an important topic in materials research. Crystallographic descriptors such as space groups and lattice parameters categorize structures theoretically, but relying on the crystal symmetry may obscure similarities in atomic arrangement. Moving beyond this could help to uncover fundamental similarities between materials from diverse crystal systems.

To explore these similarities in atomic arrangement, we conducted a comprehensive structural investigation across various fields of functional materials. The structures analyzed are primarily from three crystal systems: trigonal, hexagonal, and cubic, each characterized by significant differences in the unit cells. Despite the significant

differences in space groups and lattice constants, we found that all of these materials have atomic close-packed layers. As depicted in Figure 1A, atoms of the same kind are packed closely in a plane to form a close-packed atomic layer, these paralleled layers are stacked sequentially along the symmetry axis.¹⁰⁶ Furthermore, different characteristics of layer spacings in stacking can effectively describe distinct crystal structures and different crystal systems, as illustrated in Figure 1B–1D. For low-symmetry structures, they may not have strictly close-packed planes, but if the arrangements of “pseudo-close-packed layer” could be identified, which means cations or anions are regularly distributed near the same crystal plane, these structures can also be included in our strategy.¹⁵

From the perspective of close-packed layer spacing, the layer spacing ratio LS_{avg}/LS_{ref} is an indicator of structure geometry.¹⁵ By averaging the various layer spacings between adjacent close-packed planes, the LS_{avg} is used to characterize the overall layer spacing, indicating interlayer information, and the LS_{ref} , which is determined by the atomic distance (red “d” in Figure 1A, $LS_{ref} = d/\sqrt{6}$), serves as a reference for the intralayer information. The perspective of ‘layer spacing’ could reveal the similarity across crystal structures from different crystal systems, since the intrinsic atomic arrangement similarity may be covered up by the crystallographic descriptions of space groups and lattice constants.

A comprehensive review and analysis of reported crystal structures across numerous functional material systems have been conducted to show the linear correlation between chemical composition and structural evolution, as depicted in Figure 2.^{16–77,107} (Detailed structure information is shown in Tables S1 and S2.) The materials within each system we studied exhibit a 3-fold rotation or rotation-inversion axis, or a 6-fold axis, with atoms closely packing in a plane perpendicular to the rotation symmetry axis, highlighting the potential for the formation of materials with different structures. Take thermoelectric materials for example, a wide range of solubility can be found in these systems (indicated by red symbols in Figure 2), where the structure varies with the composition in a linear

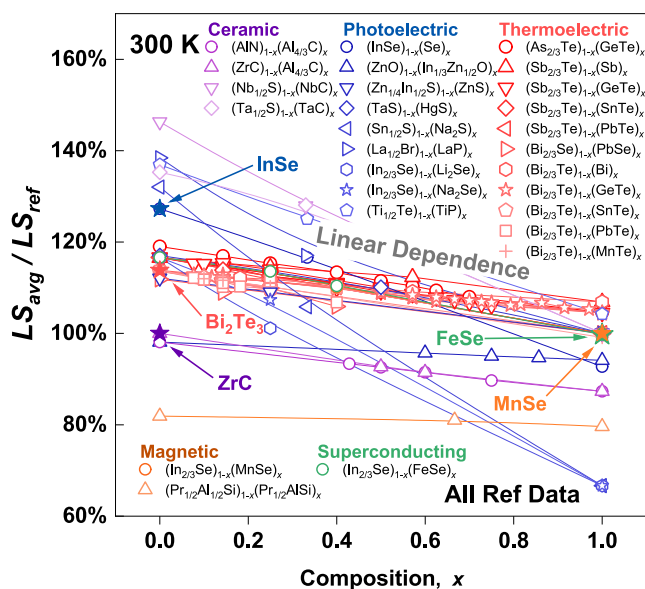


Figure 2. Relationship between the close-packed layer spacing ratio (LS_{avg}/LS_{ref}) and composition for several functional material systems when the composition ratio x changes. It should be noted that the rough classification of materials is based on their existing or potential functionalities.

relationship, and the gradual change of the LS_{avg}/LS_{ref} ratio indicates the evolution of crystal geometry.

3. STRUCTURAL UNIT EVOLUTION IN EXISTING THERMOELECTRICS

In thermoelectric materials, both group V_2-VI_3 and $IV-VI$ compounds have been extensively studied over decades due to their high-symmetry crystal structure and outstanding performance.¹⁰⁸ The structural similarity guided by close-packed layers also supports the feasibility of their solid solution.

Within the group $IV-VI$ compounds, the stoichiometry of cations and anions is equimolar, while group V_2-VI_3 compounds like Bi_2Te_3 exhibit a different cation-to-anion ratio of 2:3. As a result, the formation of new structural units within $IV-VI$ and V_2-VI_3 compounds is quite different from the atomic substitution observed in solid solutions between materials with identical atomic arrangement. From the perspective of layer spacing, the formation process can be vividly likened to “layer stacking slabs”.

Two compounds in $(Bi_{2/3}Te)_{1-x}(GeTe)_x$ are introduced as examples of layer stacking for illustration purpose. In the parent compounds Bi_2Te_3 and $GeTe$ (Figure 3A,E), their symmetry axes align with the $[001]$ crystal orientation. In Bi_2Te_3 , structural units consist of ‘Te/Bi/Te/Bi/Te’ 5 atomic layers separated by van der Waals gaps. While in the room-temperature $GeTe$, the bilayer structural units of ‘Ge/Te’ overlap parallelly without van der Waals gaps. When forming $(GeTe)_1(Bi_2Te_3)_2$ (Figure 3B,C), i.e., $GeBi_4Te_7$, one bilayer $GeTe$ unit is inserted into two 5-layer Bi_2Te_3 , resulting in a new 12-atomic-layer stacking unit separated by van der Waals gaps. Similarly, the formation of $(GeTe)_2(Bi_2Te_3)_1$, i.e., $Ge_2Bi_2Te_5$, is illustrated in Figure 3F,G.

When examining the lattice constants and space groups, the resulting structures differ greatly from the parent materials and also vary among themselves. (Bi_2Te_3 ,⁶⁹ s.g.: $R\bar{3}m$, $a = 4.39 \text{ \AA}$, $c = 30.33 \text{ \AA}$; $GeBi_4Te_7$,⁸⁶ s.g.: $P\bar{3}m1$, $a = 4.35 \text{ \AA}$, $c = 23.93 \text{ \AA}$; $Ge_2Bi_2Te_5$,⁸³ s.g.: $P\bar{3}m1$, $a = 4.30 \text{ \AA}$, $c = 17.36 \text{ \AA}$; $GeTe$,¹⁰⁷ s.g.: $R\bar{3}m$, $a = 4.17 \text{ \AA}$, $c = 10.69 \text{ \AA}$) Despite these differences, the characteristic similar ‘layer stacking slabs’ from their parent materials are evident, as illustrated in Figure 3B,F.

To verify the idea of “layer stacking slabs”, HAADF-STEM was chosen to intuitively observe the layered structures of solid solution materials formed as ‘layer stacking slabs’ from their parent compounds. The structural units of $GeBi_4Te_7$ and $Ge_2Bi_2Te_5$ were directly observed along the $[001]$ zone axis by the HAADF-STEM images (Figure 3D,H), further supporting the discussion. The observed real-space distances (the red

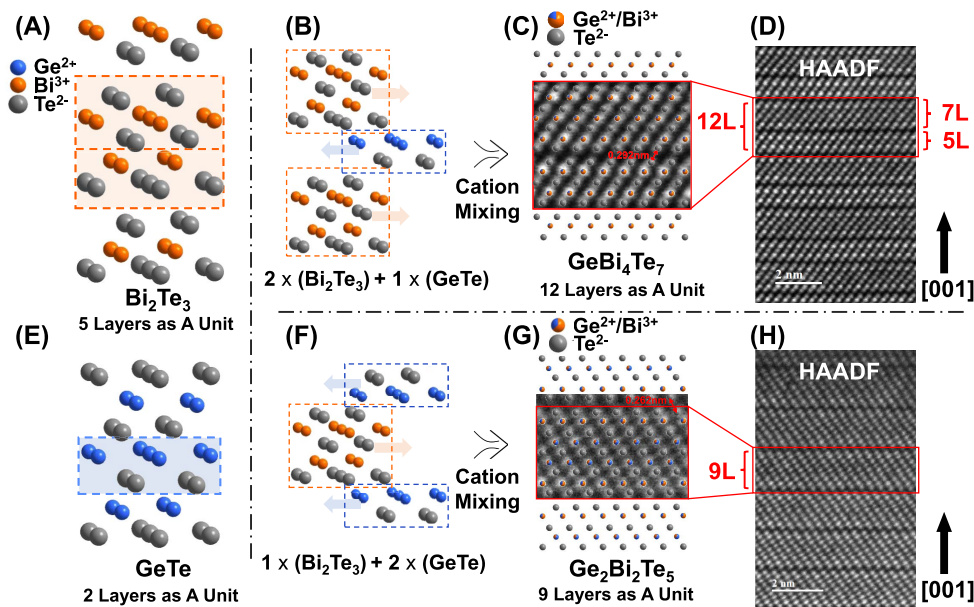


Figure 3. Schematic diagrams of crystal structures of (A) Bi_2Te_3 , (E) $GeTe$, (C) $GeBi_4Te_7$, and (G) $Ge_2Bi_2Te_5$. Structure layer stacking patterns of (B) $GeBi_4Te_7$ and (F) $Ge_2Bi_2Te_5$, and atomic resolution HAADF-STEM images focusing on the defect-free matrix along the $[001]$ zone axis of (D) $GeBi_4Te_7$ and (H) $Ge_2Bi_2Te_5$.

labels in Figure 3C,G) by imaging are highly consistent with the values calculated according to the literature data.^{83,92}

A considerable amount of literature and reported crystal structure data was reviewed for materials formed by group IV–VI and V_2 – VI_3 compounds.^{78–105,107} With the composition changing from one end to the other, the structural units vary continuously. By employing the ‘layer spacing’ guidance, the geometry indicator ($LS_{\text{avg}}/LS_{\text{ref}}$) aligns well with experimentally observed structural changes. (Detailed structure information is shown in Figure S2 and Table S2.) Meanwhile, the material system of Bi_2Te_3 – GeTe was experimentally investigated in this work. Following the solid red dots shown in Figure 4, with the GeTe content increasing in Bi_2Te_3 , the ratio

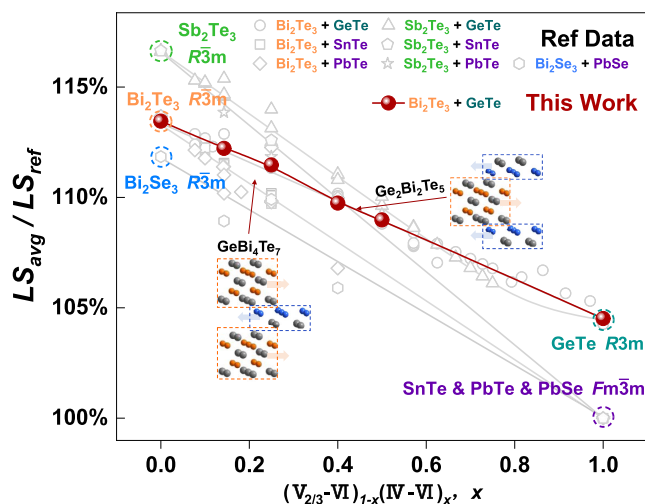


Figure 4. Relationship between the close-packed layer spacing ratio ($LS_{\text{avg}}/LS_{\text{ref}}$) and composition for IV–VI and V_2 – VI_3 alloys when the composition ratio x changes.

of layer spacings drops gradually, which indicates a change in structural units. (Detailed structural evolution information on Bi_2Te_3 – GeTe is shown in Figure S2A). Noticeably, the relationship between structure and composition follows a linear dependency, which is consistent with literature reports.^{78,79,84,89,93,94,99}

The spacing of each atomic layer can be directly calculated by the bond lengths. For most of the materials studied in this work, the average layer spacings were calculated from lattice constants and layer counts or from bond lengths recorded in crystallographic information files (CIFs). The atomic PDF gives the probability of finding atomic pairs of distance r apart beyond crystallography.^{109–111} Therefore, PDF is a straightforward characterization method to obtain quantitative bond length information, and it can provide the local structure point of view to quantitatively confirm the structural evolution during composition variation.

Five compounds were chosen for the PDF experiments. As shown in Figure 5, peaks around 3.0 Å represent the average bond lengths of neighboring atoms between adjacent layers, indicating interlayer information on indicator. The peak around 4.2 Å represents bond lengths of anion–anion or cation–cation within close-packed planes, referring to the intralayer information. With the addition of $\text{Bi}_2\text{Te}_3/\text{Sb}_2\text{Te}_3$ to GeTe , the bond lengths relevant to both inter- and intralayer information increase. The local structure refinements were

carried out to extract the atomic bond lengths, which are the basis for our proposed layer stacking material design strategy.

The PDF refinement results are shown in Figures S3,D and S3. They could be well fit by the crystallographic structures, and the corresponding bond length information is listed in Table S3. Based on the interlayer- and intralayer-related atomic distances, the corresponding LS_{avg} and LS_{ref} parameters were calculated, which aligns well with our proposed strategy, as represented in Table S3. More detailed PDF refinement results are listed in Table S4. Therefore, the experimentally determined local structure bond lengths align well with the average structure obtained from XRD data in Figure S2A,B, which confirms the structural evolution of “layer stacking slabs”.

4. NEW POSSIBLE THERMOELECTRIC MATERIALS BY LAYER STACKING

In this work, the structural similarities across materials with different crystal structures and cation-to-anion ratios were investigated, highlighting the potential for the formation of solid solutions between these materials. In the (IV–VI)–(V_2 – VI_3) system studied above, group V_2 – VI_3 compounds have van der Waals layers, while group IV–VI compounds do not. Consequently, the $(V_{2/3}-VI)_{1-x}(IV-VI)_x$ alloys with non-equimolar cation-to-anion ratio would differ from other equimolar substituted solid solutions.

When adding a small amount of group IV–VI compounds into group V_2 – VI_3 compounds, the solid solution retains the structure of the matrix material. It can be inferred that the material will inevitably contain some atomic vacancies or interstitial atoms within its structure.^{112,113} As the composition approaches a specific ratio, such as $(\text{GeTe})_2(\text{Sb}_2\text{Te}_3)_1$, these vacancies or interstitial atoms tend to occupy crystallographic sites in an ordered manner, thereby forming or filling vacancy layer van der Waals gaps and resulting in a layered structure different from the matrix material. These new materials have opened new possibilities for discovering high-performance materials in the fields of thermoelectric and phase change memory.^{114,115}

In our previous work, the structural similarities between group I–V– VI_2 and IV–VI compounds were established through a ‘layer spacing’ perspective, including binary and ternary compounds with orthorhombic, trigonal, and cubic crystal systems.¹⁵ Based on the layer stacking similarities between I–V– VI_2 and IV–VI, and IV–VI and V_2 – VI_3 , here we infer that the I–V– VI_2 compounds could potentially alloy with the V_2 – VI_3 compounds to form single-phase solid solutions.

Therefore, numerous material systems of group V_2 – VI_3 and I–V– VI_2 compounds were experimentally studied as follows. For group V_2 – VI_3 compounds, Sb_2Te_3 , Bi_2Se_3 , Bi_2Te_3 , and Sb_2Se_3 were chosen. The space group of the former three is $R\bar{3}m$ which belongs to the trigonal phase, but the last one is $Pnma$ which belongs to the orthorhombic phase. Although Sb_2Se_3 does not have close-packed planes in structure, it may obtain a similar atomic arrangement as Sb_2Te_3 while Te atoms partly substitute the position of Se atoms.¹¹⁶ For group I–V– VI_2 compounds, AgSbSe_2 , AgBiSe_2 , AgSbTe_2 , and AgBiTe_2 were chosen for solid solution experiments. AgSbSe_2 and AgSbTe_2 are $Fm\bar{3}m$ which belongs to the cubic phase, and AgBiSe_2 and AgBiTe_2 are $P\bar{3}m1$ which belongs to the trigonal phase. Only AgBiTe_2 is unstable at room temperature.¹¹⁷ However, through the Sb atoms’ partial substitution in Bi atom

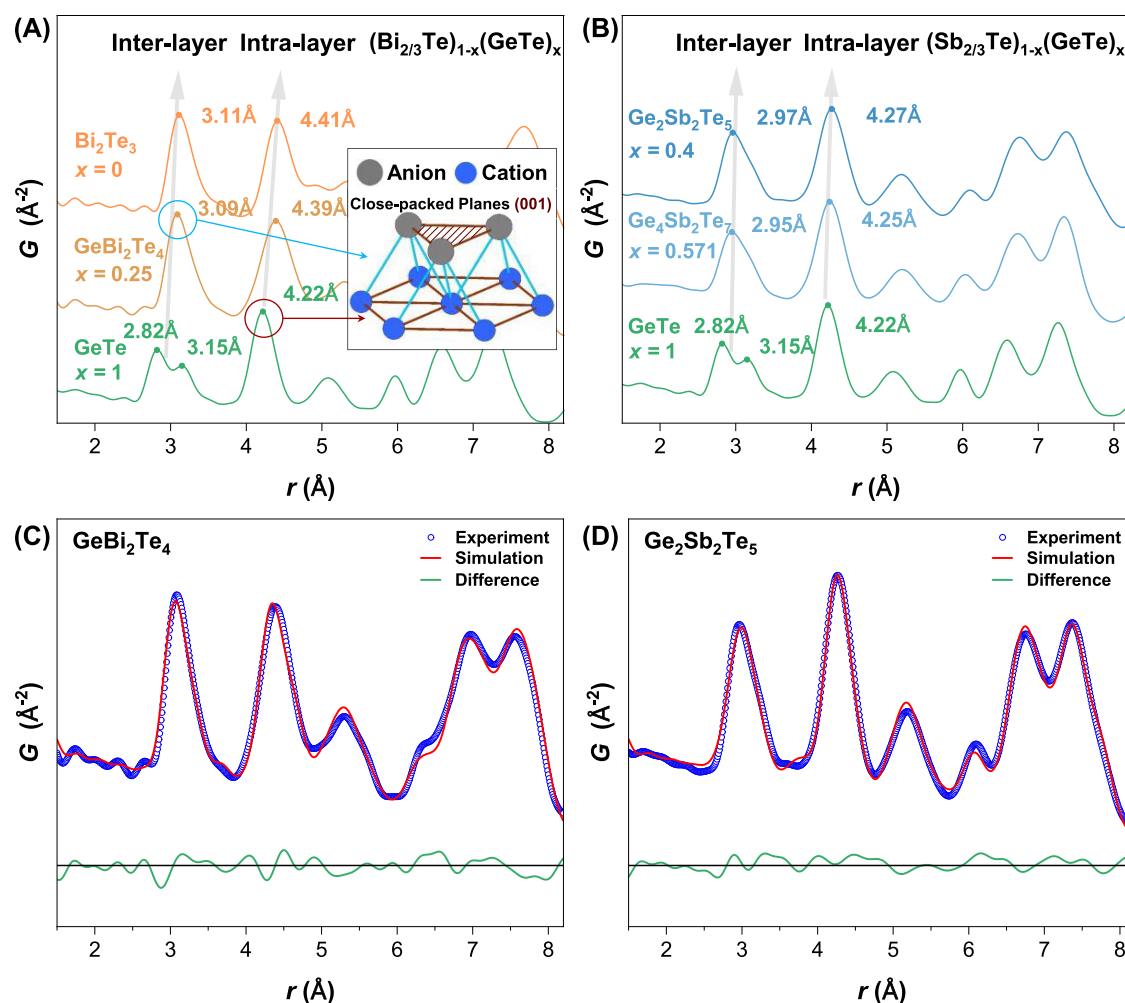


Figure 5. Synchrotron experimental X-ray atomic PDF data of (A) $(\text{Bi}_{2/3}\text{Te})_{1-x}(\text{GeTe})_x$ and (B) $(\text{Sb}_{2/3}\text{Te})_{1-x}(\text{GeTe})_x$ compounds. The experimental X-ray PDF data (blue curves) of (C) GeBi_2Te_4 and (D) $\text{Ge}_2\text{Sb}_2\text{Te}_5$ are fit by the corresponding phase models (red curves) over the range of $1.5 < r < 8.2$ Å. The difference curves (green) are shown offset below.

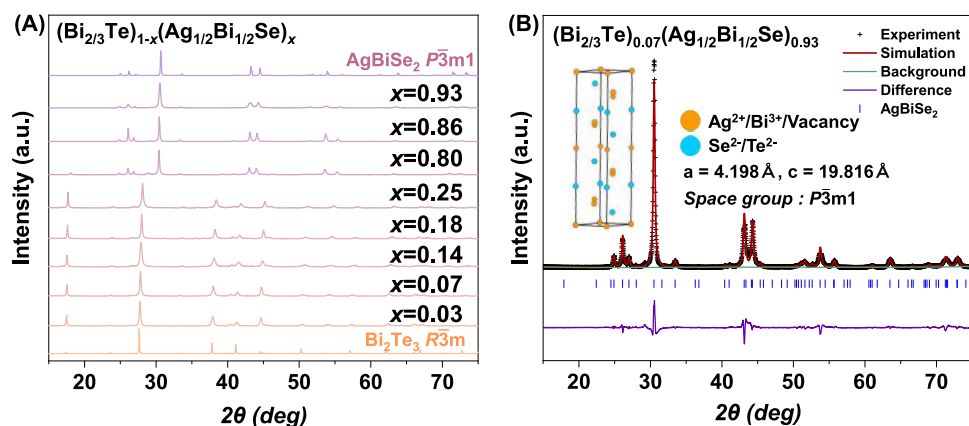


Figure 6. (A) XRD patterns of different solid solution alloys of Bi_2Te_3 and AgBiSe_2 and (B) XRD Rietveld refinements result of $(\text{Bi}_{2/3}\text{Te})_{0.07}(\text{Ag}_{1/2}\text{Bi}_{1/2}\text{Se})_{0.93}$.

positions or Se atoms' partial substitution in Te atom positions, the solid solution may become stable.^{117,118}

In some of these solid solution systems, we successfully obtained stable solid solutions with considerable solubility. (The XRD patterns of all different solid solutions tested are shown in Figure S4.) Taking the AgBiSe_2 – Bi_2Te_3 material system as an example, the experimental XRD patterns are

shown in Figure 6A, and we achieved a solubility of 20% for Bi_2Te_3 in AgBiSe_2 , and conversely, about 25% for AgBiSe_2 in Bi_2Te_3 in this work. As the composition increased, the XRD peaks gradually shift, confirming the structural variation in this solid solution system.

Structural Rietveld refinements were performed on the obtained samples, and detailed structural information can be

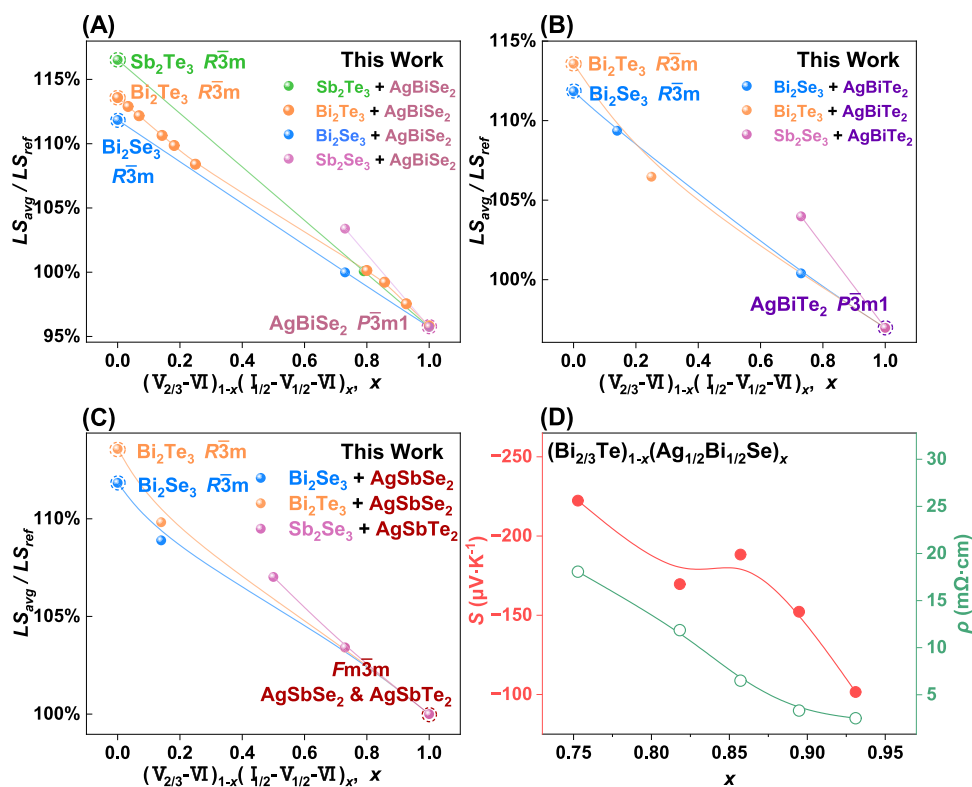


Figure 7. Relationship between (A–C) the close-packed layer spacing ratio (LS_{avg}/LS_{ref}) and (D) performance and composition for V_2-VI_3 and $I-V-VI_2$ alloys when the composition ratio x changes.

found in Tables S5–S11 and Figures S5 and S6. The refined structures (in .cif format) are provided in the Supporting Information. The $(Bi_{2/3}Te)_{0.07}(Ag_{1/2}Sb_{1/2}Te)_{0.93}$ sample from the $AgBiSe_2-Bi_2Te_3$ series was selected as an example. As shown in Figure 6B, when a small amount of Bi_2Te_3 was added to $AgBiSe_2$, no new diffraction peaks appeared in the XRD of the alloy compared to the pristine $AgBiSe_2$. Only the position of the diffraction peaks shifted, and the relative peak intensities changed. Therefore, we concluded that the change in the crystal structure due to the addition of Bi_2Te_3 was reflected in the lattice constants and did not change the symmetry of alloys. The synthesized alloys were refined using the crystal structure of the parent phase $AgBiSe_2$ ¹¹⁹ (s.g.: $P3m1$), and a satisfactory fit was obtained, as shown in Figure 6B. The specific refinement results are shown in Table S6.

As shown in Figures 6 and S4, all synthesized materials maintain the crystal structure of matrix material, which also occurred in the low content solid solution of the classical $GeTe-Bi_2Te_3$ material system. Solid solutions with a special proportion of composition ratio were synthesized in the $AgBiSe_2-Bi_2Te_3$ series. No new Bragg peaks were found in XRD patterns, which indicates that no new structure was obtained. Although no compounds with new structures, such as in the classical $GeTe-Bi_2Te_3$ material system, were obtained by “layer stacking slabs”, quite a number of new solid solution material systems were investigated preliminarily by the strategy, which may expand the thermoelectric research field.

By analyzing the crystal structures obtained from XRD Rietveld refinements, we identified a linear relationship in the new V_2-VI_3 and $I-V-VI_2$ solid solution, as illustrated in Figure 7A–7C. With a gradual increase in the composition of $I-V-VI_2$ group compounds, the ratio of the average layer

spacing to the reference layer spacing (LS_{avg}/LS_{ref}) gradually decreases.

Some samples from the $AgBiSe_2-Bi_2Te_3$ series were selected for thermoelectric performance testing. With the increase of Bi_2Te_3 content in $AgBiSe_2$, the resistivity ($\rho = 1/\sigma$) of the material increases gradually, and the Seebeck coefficient ($S = dV/dT$) also shows an increasing trend, as shown in Figure 7D. More detailed thermoelectric property results are listed in Table S12. The performance test results demonstrate that these samples, designed by “layer stacking slabs”, could be promising candidates for thermoelectrics.

Implementing the “layer stacking slabs” guideline, the potential solid solutions between materials with similar stacking patterns could lead to new material discoveries, as demonstrated in the new material system $(V_{2/3}-VI)_{1-x}(I_{1/2}-V_{1/2}-VI)_x$. Furthermore, compounds with similar stacking structures may also be designed by this general guideline, which could significantly broaden the research scope of functional materials across different fields.

Besides, with the recent advancements in high-throughput synthetic methods of new inorganic materials,¹²⁰ which are usually based on fine-grid searches across the entire composition space, our layer-stacking-oriented structure manipulation approach could potentially integrate with these methods to further accelerate the material discovery in a more experimentally practical way.

5. CONCLUSIONS

The commonly existing close-packed atomic layers in different functional materials across crystal symmetries were investigated systematically by using literature data and experimental observations. The interlayer structure was found to be easily modified, and thus the “layer stacking slabs”, as a concise and

practical pathway, was proposed for the structural unit evolution of solid solutions and compounds. By following the layer spacing indicator of a linear dependency between structure symmetry and composition, it becomes possible to step over the boundaries between different crystal systems and fine-tune atomic structures in an experimentally feasible way. For instance, a new thermoelectric material system of $(I-V-VI_2)-(V_2-VI_3)$ has been successfully synthesized. The “layer stacking slabs” guideline could provide new opportunities for designing novel functional materials across various fields in the future.

6. EXPERIMENTAL SECTION

In this work, samples of 12 systems were synthesized, which were $(Bi_{2/3}Te)_{1-x}(GeTe)_x$ ($x = 0, 0.143, 0.25, 0.4, 0.5, 1$), $(Sb_{2/3}Te)_{1-x}(GeTe)_x$ ($x = 0.4, 0.571, 1$), $(Sb_{2/3}Te)_{1-x}(Ag_{1/2}Bi_{1/2}Se)_x$ ($x = 0, 0.15, 1$), $(Bi_{2/3}Te)_{1-x}(Ag_{1/2}Bi_{1/2}Se)_x$ ($x = 0, 0.034, 0.069, 0.143, 0.182, 0.25, 0.8, 0.857, 0.927, 1$), $(Bi_{2/3}Se)_{1-x}(Ag_{1/2}Bi_{1/2}Se)_x$ ($x = 0.33, 0.8, 1$), $(Sb_{2/3}Se)_{1-x}(Ag_{1/2}Bi_{1/2}Se)_x$ ($x = 0.4, 0.8, 1$), $(Bi_{2/3}Te)_{1-x}(Ag_{1/2}Bi_{1/2}Te)_x$ ($x = 0.33$), $(Bi_{2/3}Se)_{1-x}(Ag_{1/2}Bi_{1/2}Te)_x$ ($x = 0.2, 0.8$), $(Sb_{2/3}Se)_{1-x}(Ag_{1/2}Bi_{1/2}Te)_x$ ($x = 0.2, 0.8$), $(Bi_{2/3}Te)_{1-x}(Ag_{1/2}Sb_{1/2}Se)_x$ ($x = 0.2, 0.8$), $(Bi_{2/3}Se)_{1-x}(Ag_{1/2}Sb_{1/2}Se)_x$ ($x = 0.2, 0.8$), $(Sb_{2/3}Se)_{1-x}(Ag_{1/2}Sb_{1/2}Te)_x$ ($x = 0.6, 0.8$). The elements weighed according to the stoichiometry were sealed in vacuum quartz tubes, heated to 850 °C, and 877 °C for the first two material systems, and 1000 °C for the others, and then held for about 6 h. They were quenched in water, then annealed for 1 day at 500, 600 °C for the first two material systems, and 500 °C for the others and cooled to room temperature in the furnace. The purity of all of the elements used to synthesize the samples was higher than 99.99%. For X-ray powder diffraction (XRD) experiments, the ingots obtained were ground into fine powders that passed through a 300-mesh sieve. All powder samples were characterized by D8 Advance (BRUKER) with Cu K_{α} radiation $\lambda = 1.5406 \text{ \AA}$.

Dense bulk samples of $(Bi_{2/3}Te)_{1-x}(Ag_{1/2}Bi_{1/2}Se)_x$ ($x = 0.07, 0.11, 0.14, 0.18, 0.25$), $(Sb_{2/3}Te)_{1-x}(Ag_{1/2}Bi_{1/2}Se)_x$ ($x = 0.79, 0.86$), $(Bi_{2/3}Se)_{1-x}(Ag_{1/2}Bi_{1/2}Se)_x$ ($x = 0.11, 0.12, 0.14$), $(Sb_{2/3}Se)_{0.27}(Ag_{1/2}Bi_{1/2}Se)_{0.73}$, $(Bi_{2/3}Te)_{0.27}(Ag_{1/2}Sb_{1/2}Se)_{0.73}$, were obtained by a vacuum induction heating system at a temperature of 573 K (for $(Bi_{2/3}Te)_{1-x}(Ag_{1/2}Bi_{1/2}Se)_x$) or 723 K (for the others) and a uniaxial pressure of 80 MPa for 40 min. The resistivity was determined by the van der Pauw method. For testing the Seebeck coefficient, K-type thermocouples were adhered to the radial sides of the samples to measure the thermal power and temperature difference.

The Rietveld refinements of the XRD data were performed by the GSAS-II software.¹²¹ The refined crystal structures were then exported, and relevant spatial information was calculated from them. All crystallographic information files (CIFs) used for structural modeling and calculations were from the Inorganic Crystal Structure Database (ICSD).^{122,123}

The synchrotron X-ray PDF measurements were carried out at the BL08W beamline at the Super Photon ring-8 GeV (Spring-8) in Japan. PDF data reduction and processing were performed by the pyFAI and PDFgetX3 programs.^{124,125} A detailed description of the PDF experiment and data processing can be found in the Supporting Information.

■ ASSOCIATED CONTENT

SI Supporting Information

The Supporting Information is available free of charge at <https://pubs.acs.org/doi/10.1021/acs.chemmater.4c02062>.

The crystallographic information files (CIFs) from the Rietveld refinement results of the samples (ZIP)

Detailed structural information on the investigated materials, XRD and Rietveld refinement results of the

samples, synchrotron X-ray pair distribution function analysis, and thermoelectric performance (PDF)

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Notes

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